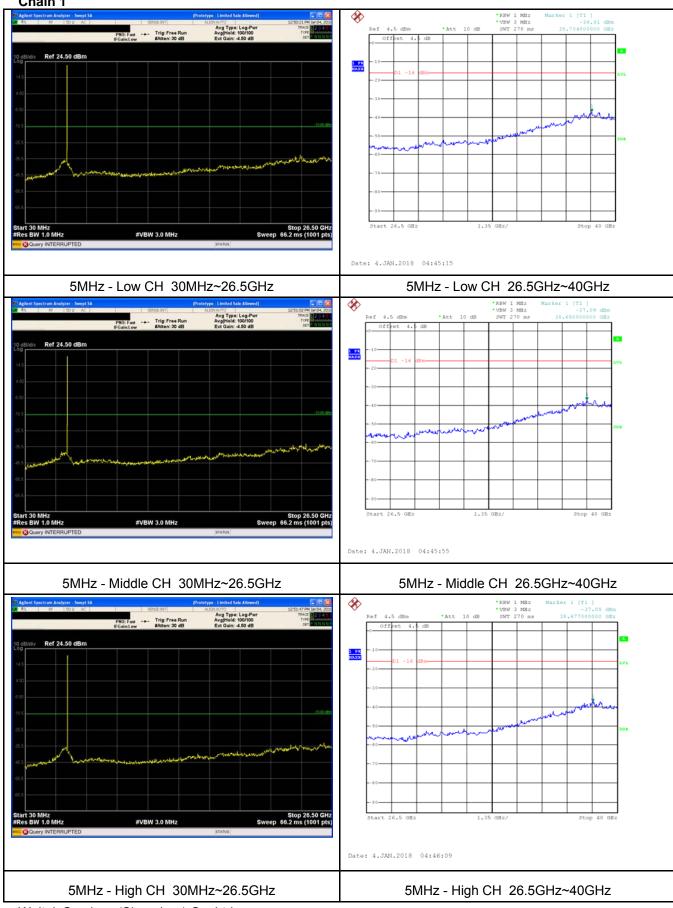
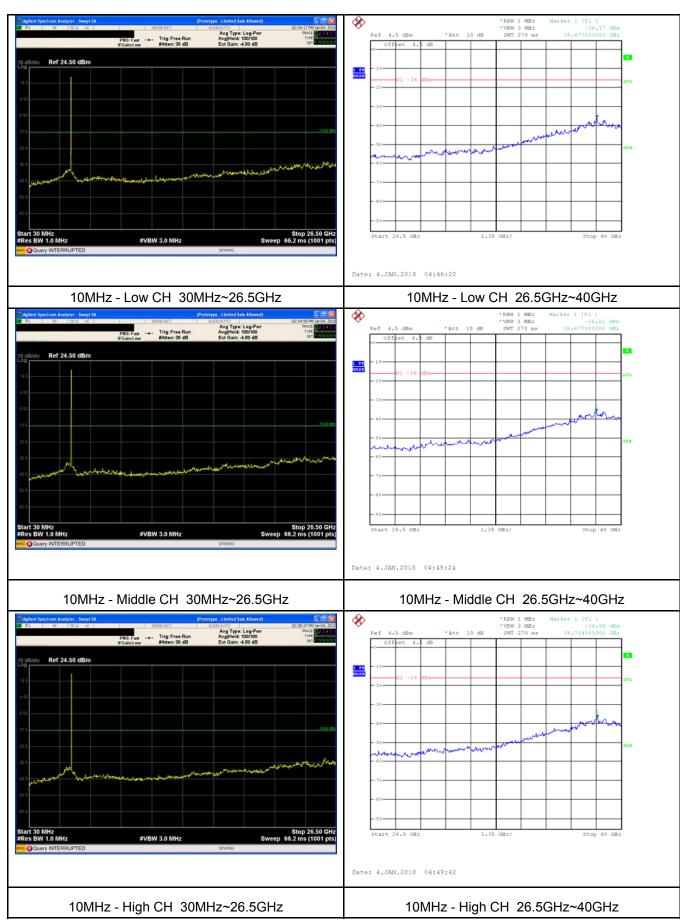


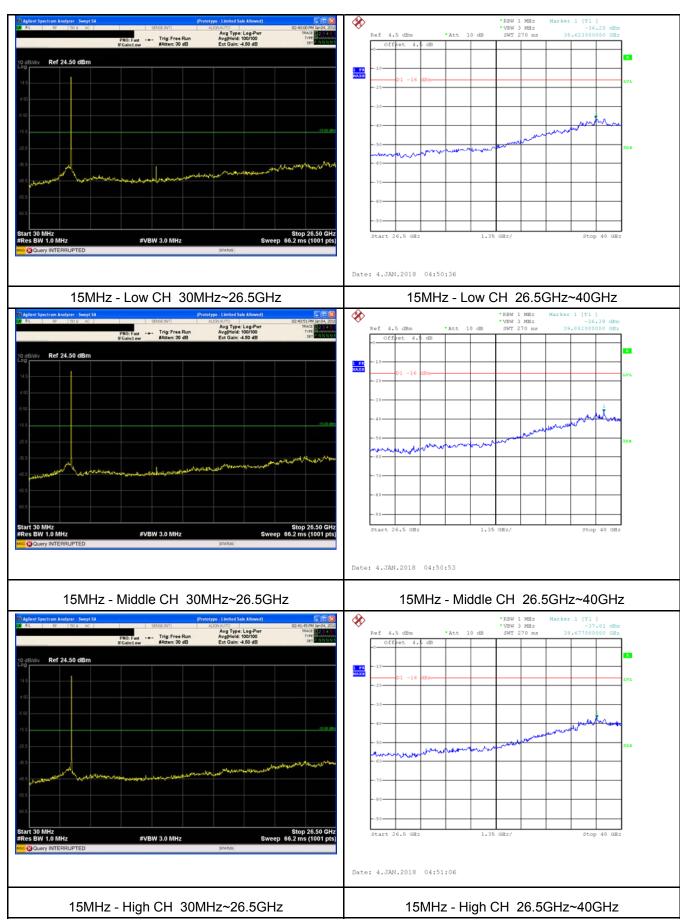
Waltek Services (Shenzhen) Co.,Ltd. http://www.waltek.com.cn

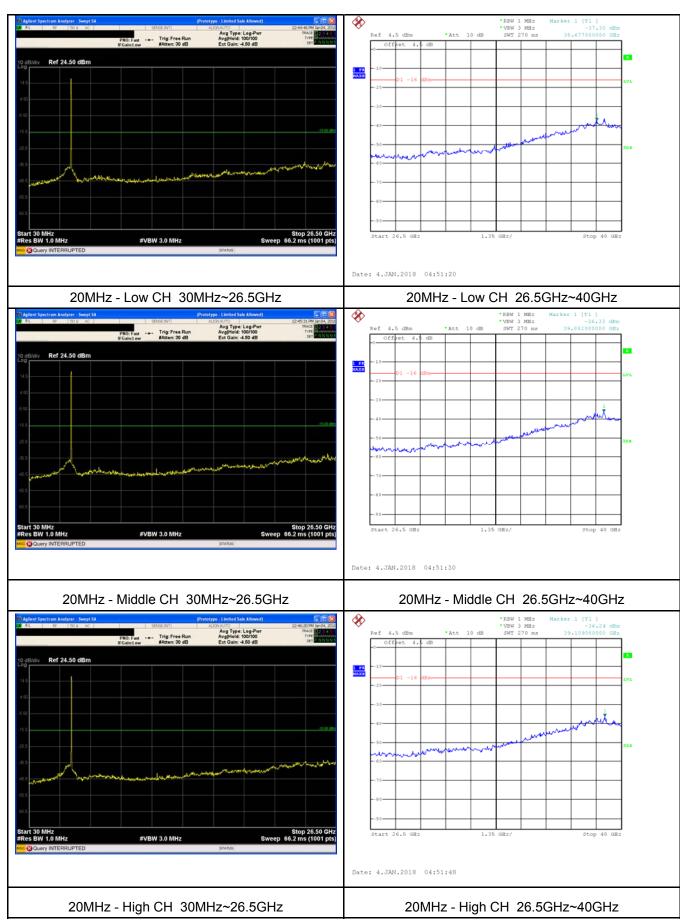




Waltek Services (Shenzhen) Co.,Ltd. http://www.waltek.com.cn

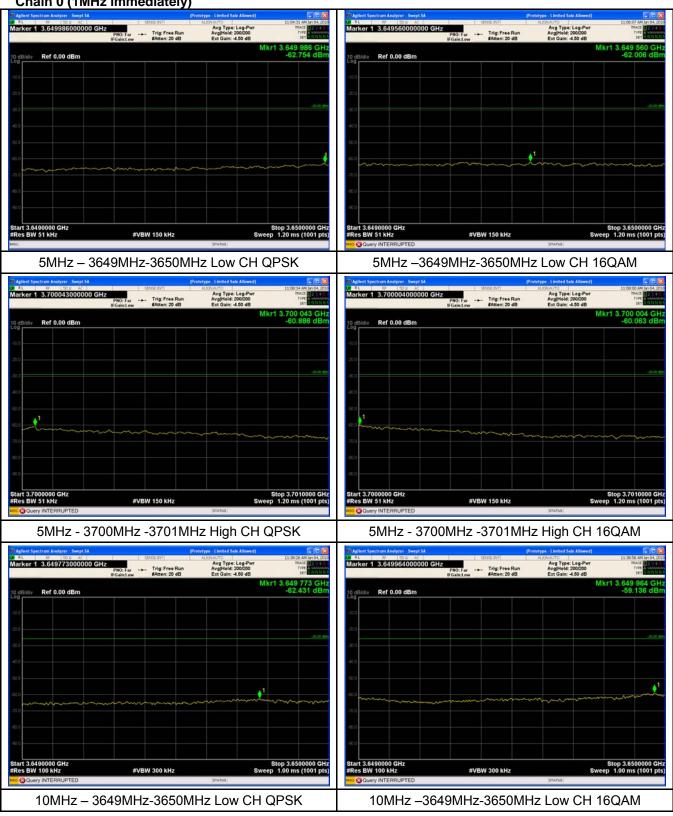


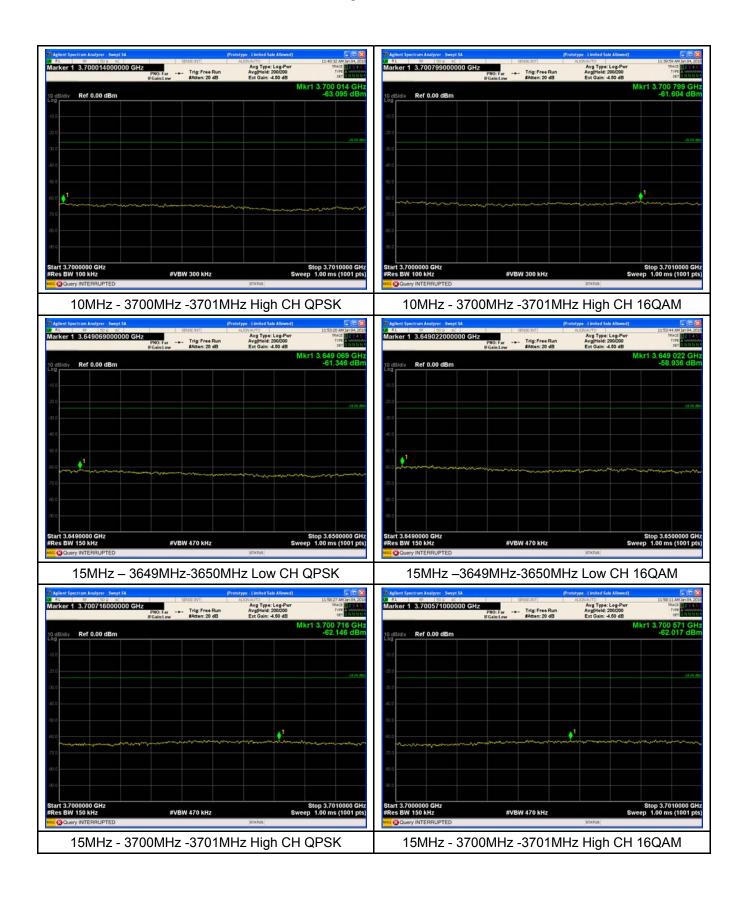


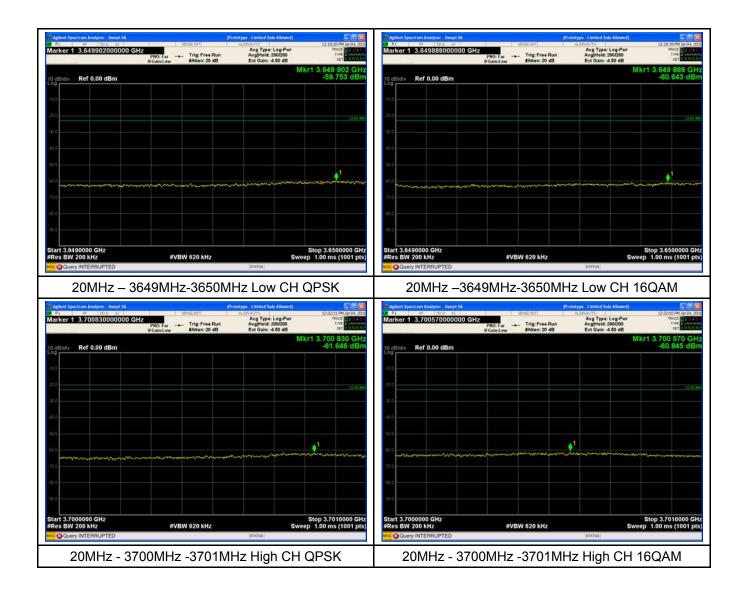


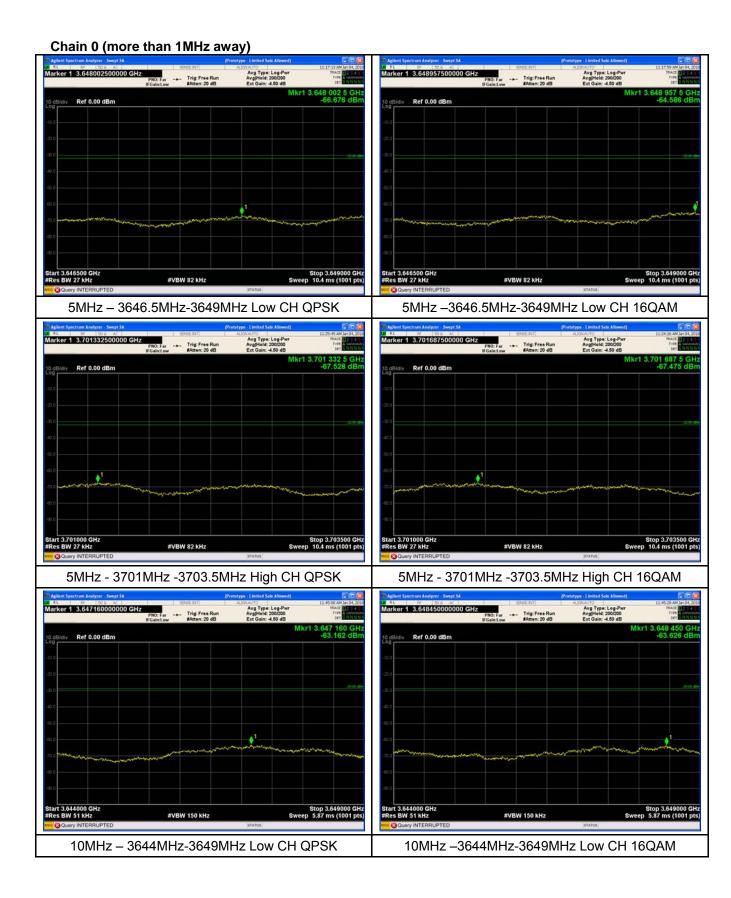
Waltek Services (Shenzhen) Co.,Ltd. http://www.waltek.com.cn

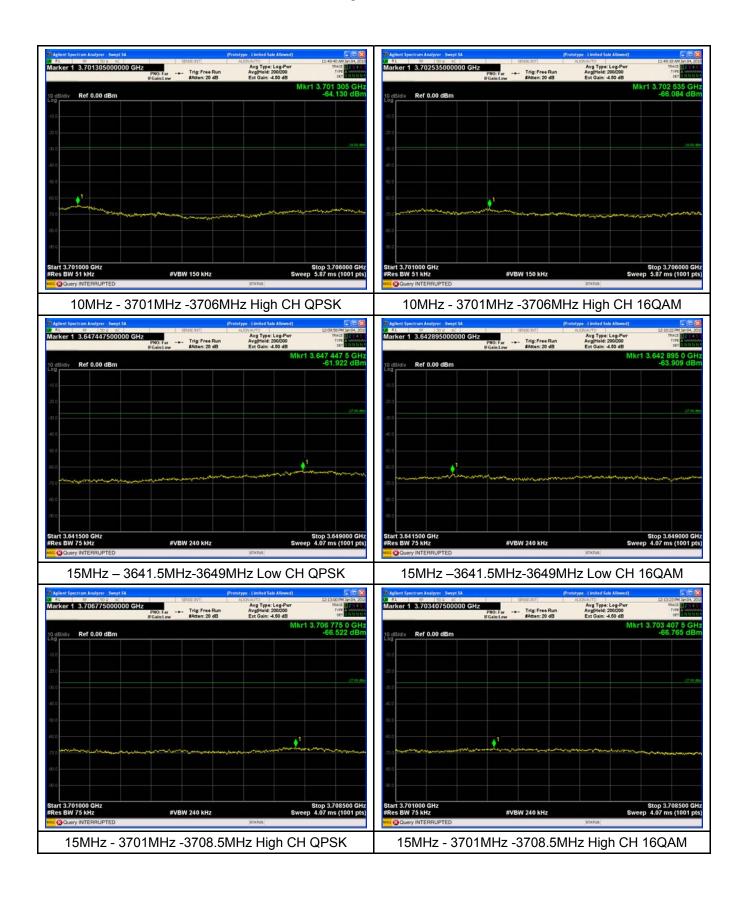


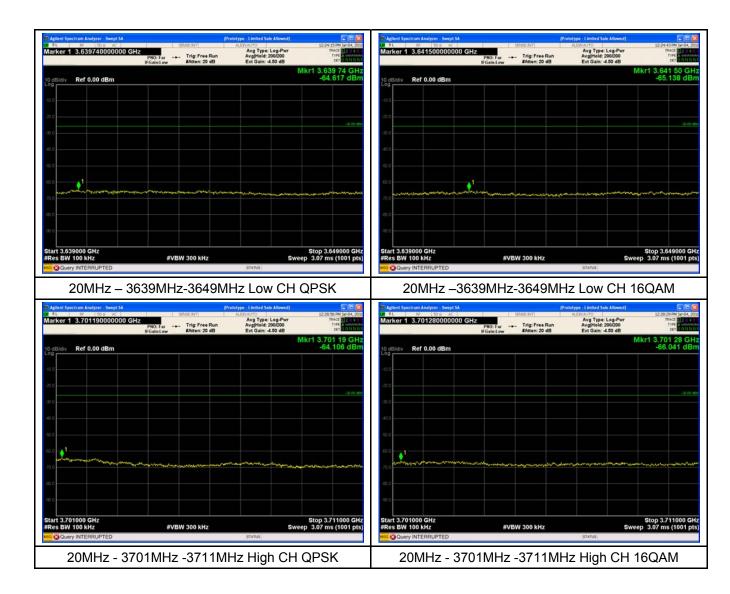




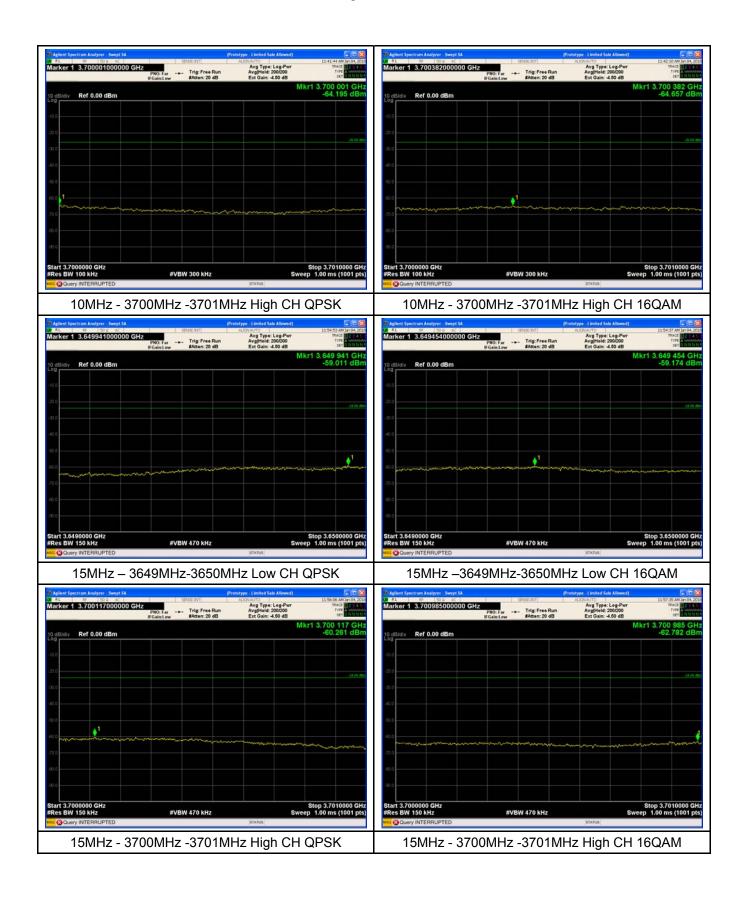


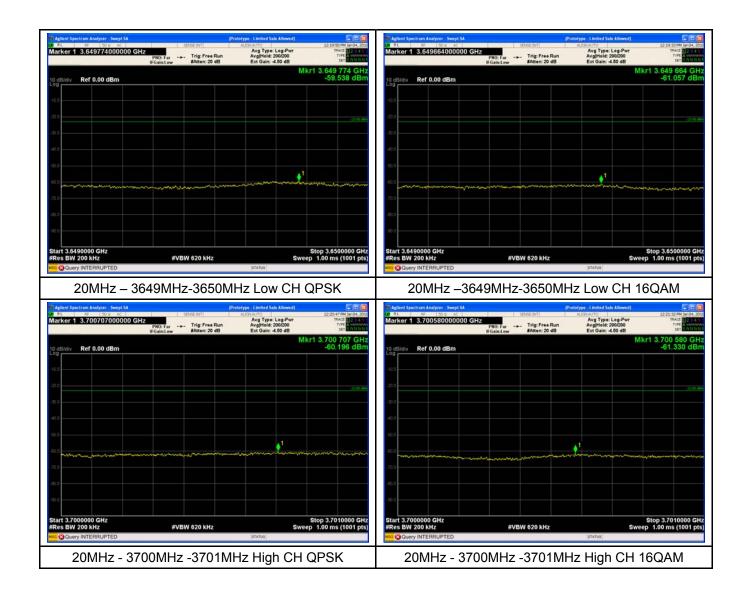


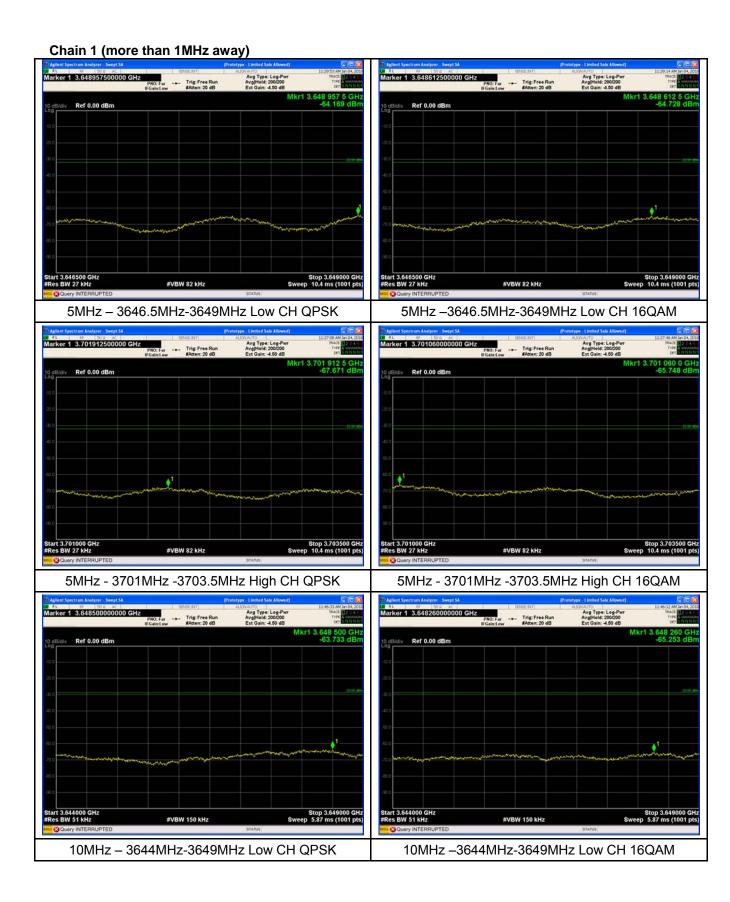


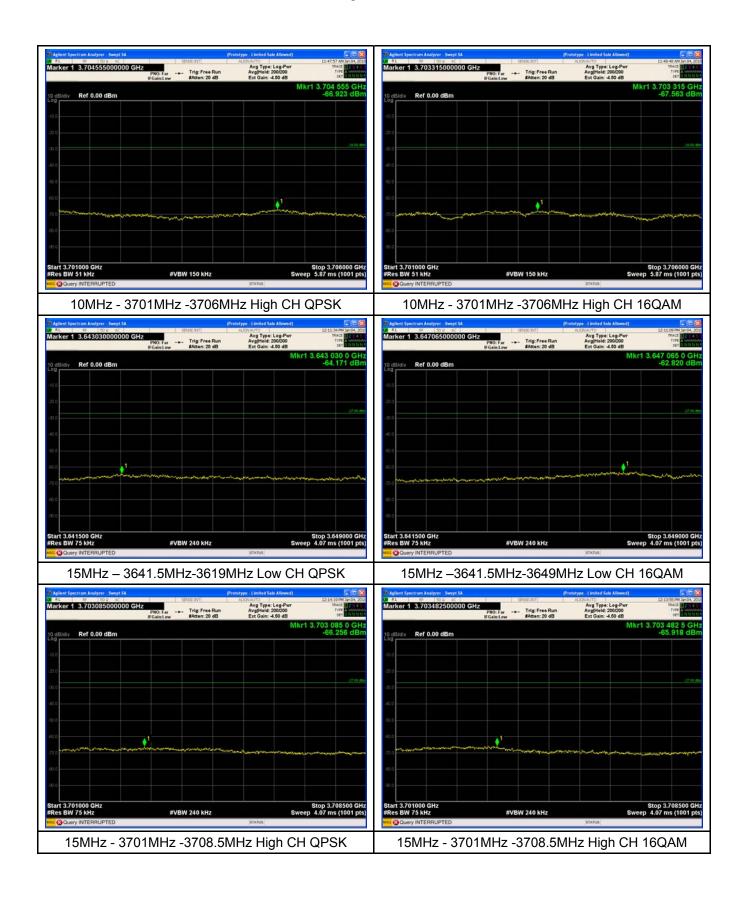


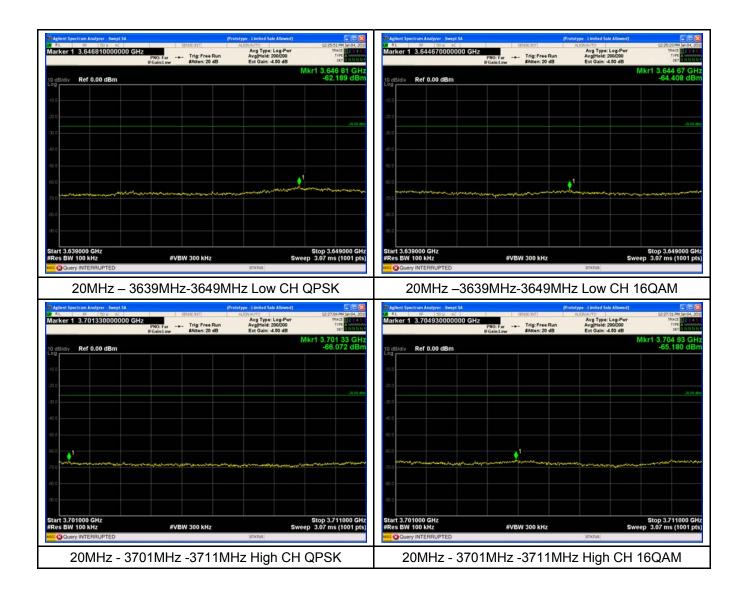












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12 Field strength of spurious radiation measurement

Test Requirement: FCC part90.1323
Test Method: FCC part2.1051

ANSI/TIA-603-E-2016

Test Mode: Data communicating mode

Limit: -13dBm

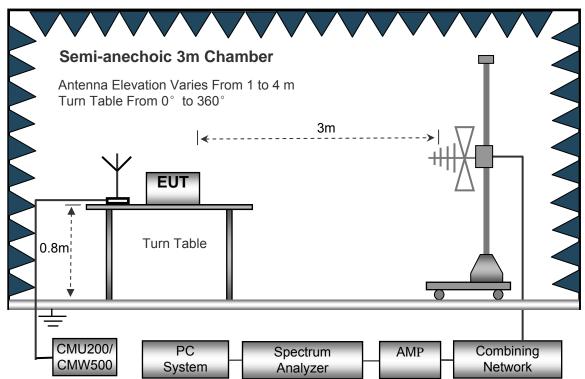
12.1 EUT Operation

Operating Environment:

Temperature: 23.5 °C
Humidity: 52.1 % RH
Atmospheric Pressure: 101.2kPa

12.2 Test Setup

The radiated emission tests were performed in the 3m Semi- Anechoic Chamber test site. The test setup for emission measurement from 30 MHz to 1 GHz.



Semi-anechoic 3m Chamber Antenna Elevation Varies From 1 to 4 m Turn Table From 0° to 360° 3m **EUT** 0.8m Turn Table CMU200/ PC Combining Spectrum AMF CMW500 Network System Analyzer

The test setup for emission measurement above 1 GHz.

12.3 Spectrum Analyzer Setup

30MHz ~ 1GHz

Sweep Speed Auto

Detector PK

Resolution Bandwidth 100kHz

Video Bandwidth 300kHz

Above 1GHz

Sweep Speed	Auto
Detector	PK
Resolution Bandwidth	1MHz
Video Bandwidth	3MHz
Detector	Ave.
Resolution Bandwidth	1MHz
Video Bandwidth	10Hz

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12.4 Test Procedure

1. The EUT was placed on an non-conductive turntable using a non-conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer.

- 2. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.
- 3. The frequency range up to tenth harmonic was investigated for each of three fundamental frequency (low, middle and high channels). Once spurious emission was identified, the power of the emission was determined using the substitution method.
- 4. The spurious emissions attenuation was calculated as the difference between radiated power at the fundamental frequency and the spurious emissions frequency.

ERP / EIRP = S.G. output (dBm) + Antenna Gain(dB/dBi) – Cable Loss (dB)

12.5 Test Result

30MHz-18GHz

Remark: During the test, pre-scan the QPSK, 16QAM modulation, and found the QPSK modulation and 10MHz bandwitch is the worst case.

	_	Turn	RX An	tenna	Su	bstituted			Res	sult
Frequency	Receiver Reading	table Angle	Height	Polar	SG Level	Cable	Antenna Gain	Absolute Level	Limit	Margin
(MHz)	(dBµV)	Degree	(m)	(H/V)	(dBm)	(dB)	(dB)	(dBm)	(dBm)	(dB)
			I		Low channel			T		
199.52	37.79	221	1.5	Н	-72.72	0.15	0.00	-72.87	-13.00	-59.87
199-52	29.73	22	1.6	V	-77.86	0.15	0.00	-78.01	-13.00	-65.01
7310.00	65.95	20	1.2	Н	-43.29	2.79	12.70	-33.38	-13.00	-20.38
7310.00	59.98	283	1.0	V	-48.79	2.79	12.70	-38.88	-13.00	-25.88
10965.00	53.58	99	1.8	Н	-52.96	3.12	11.50	-44.58	-13.00	-31.58
10965.00	44.73	226	1.9	V	-60.70	3.12	11.50	-52.32	-13.00	-39.32
	,		т		Middle channe	el		1		
199.52	38.47	188	1.8	Н	-72.04	0.15	0.00	-72.19	-13.00	-59.19
199-52	29.36	241	2.2	V	-78.23	0.15	0.00	-78.38	-13.00	-65.38
7350.00	58.91	166	1.7	Н	-50.33	2.37	12.50	-40.20	-13.00	-27.20
7350.00	53.74	277	1.4	V	-55.03	2.37	12.50	-44.90	-13.00	-31.90
11025.00	46.66	199	1.6	Н	-59.88	3.12	11.50	-51.50	-13.00	-38.50
11025.00	37.58	281	2.1	V	-67.85	3.12	11.50	-59.47	-13.00	-46.47
					High channel					
199.52	38.86	101	1.1	Н	-71.65	0.15	0.00	-71.80	-13.00	-58.80
199-52	30.13	346	1.7	V	-77.46	0.15	0.00	-77.61	-13.00	-64.61
7390.00	51.22	232	1.5	Н	-58.19	2.37	12.50	-48.06	-13.00	-35.06
7390.00	47.62	232	1.2	V	-61.15	2.37	12.50	-51.02	-13.00	-38.02
11085.00	40.40	18	1.2	Н	-64.83	3.12	11.50	-56.45	-13.00	-43.45
11085.00	29.86	202	2.1	V	-75.03	3.12	11.50	-66.65	-13.00	-53.65

Remark:

Test Frequency: 18GHz~25GHz

The measurements were more than 20 dB below the limit and not recorded

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13 Frequency stability V.S. Temperature measurement

Test Requirement: FCC Part90.213(a)

Test Method: FCC Part2.1055(a)(1)(b)

ANSI/TIA-603-E-2016

Test Mode: Data communicating mode

Limit: FCC:

Frequency range (MHz)	Fixed and base stations (±ppm)	Mobile stat	tions (±ppm)
Frequency range (WHZ)	Fixed and base stations (appm)	Over 2 watts output power	2 watts or less output power
Below 25	100	100	200
25-50	20	20	50
72-76	5		50
150-174	5	5	50
216-220	1.0		1.0
220-222	0.1	1.5	1.5
421-512	2.5	5	5
806-809	1.0	1.5	1.5
809-824	1.5	2.5	2.5
851-854	1.0	1.5	1.5
854-869	1.5	2.5	2.5
896-901	0.1	1.5	1.5
902-928	2.5	2.5	2.5
902-928	2.5	2.5	2.5
929-930	1.5		
935-940	0.1	1.5	1.5
1427-1435	300	300	300
Above 2450			

13.1 EUT Operation

Operating Environment:

Temperature: 23.5 °C

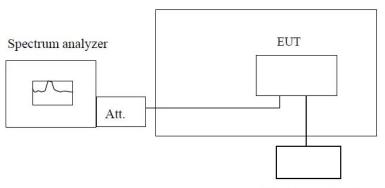
Humidity: 52.3 % RH

Atmospheric Pressure: 101.3kPa

13.2 Test Procedure

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators.
- 3. The EUT was placed inside the temperature chamber.
- 4. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 25℃ operating frequency as reference frequency.
- 5. Turn EUT off and set the chamber temperature to $-30\,^{\circ}$ C. After the temperature stabilized for approximately 30 minutes recorded the frequency.
- 6. Repeat step measure with 10℃ increased per stage until the highest temperature of +50℃ reached.

Temperature Chamber



Variable Power Supply

Note: Measurement setup for testing on Antenna connector

13.3 Test Result

Remark: All three channels of all modulations have been tested, but only the worst channel and the worst modulation show in this test item.

	Test Frequency: 3652.5MHz QPSK 5MHz					
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)			
-40		103	0.0282			
-25		106	0.0290			
-10		105	0.0287			
0		103	0.0282			
10	120	107	0.0293			
20		110	0.0301			
30		106	0.0290			
40		109	0.0298			
55		111	0.0304			

	Test Frequency: 3655MHz QPSK 10MHz					
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)			
-40		106	0.0290			
-25		105	0.0287			
-10		108	0.0295			
0		112	0.0306			
10	120	120	0.0328			
20		114	0.0312			
30		105	0.0287			
40		116	0.0317			
55		118	0.0323			

	Test Frequency: 3657.5MHz QPSK 15MHz					
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)			
-40		108	0.0295			
-25		103	0.0282			
-10		101	0.0276			
0		105	0.0287			
10	120	114	0.0312			
20		104	0.0284			
30		103	0.0282			
40		100	0.0273			
55		104	0.0284			

	Test Frequency: 3660MHz QPSK 20MHz					
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)			
-40		107	0.0292			
-25		116	0.0317			
-10	120	114	0.0311			
0		109	0.0298			
10		104	0.0284			
20		101	0.0276			
30		102	0.0279			
40		118	0.0322			
55		109	0.0298			

	Test Frequency: 3652.5MHz QPSK 5MHz					
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)			
-40		101	0.0277			
-25		101	0.0277			
-10		107	0.0293			
0		106	0.0290			
10	120	112	0.0307			
20		98	0.0268			
30		114	0.0312			
40		106	0.0290			
55		99	0.0271			

	Test Frequency: 3655MHz QPSK 10MHz						
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)				
-40		103	0.0282				
-25		102	0.0279				
-10		118	0.0323				
0		109	0.0298				
10	120	115	0.0315				
20		106	0.0290				
30		117	0.0320				
40		107	0.0293				
55		118	0.0323				

	Test Frequency: 3657.5MHz QPSK 15MHz					
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)			
-40		117	0.0320			
-25		108	0.0295			
-10		113	0.0309			
0		112	0.0306			
10	120	117	0.0320			
20		119	0.0325			
30		115	0.0314			
40		114	0.0312			
55		116	0.0317			

	Test Frequency: 3660MHz QPSK 20MHz					
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)			
-40		115	0.0314			
-25	120	108	0.0295			
-10		123	0.0336			
0		115	0.0314			
10		111	0.0303			
20		107	0.0292			
30		110	0.0301			
40		106	0.0290			
55		120	0.0328			

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14 Frequency stability V.S. Voltage measurement

Test Requirement: FCC Part90.213(a)

Test Method: FCC Part2.1055(a)(1)(b)

ANSI/TIA-603-E-2016

Test Mode: Data communicating mode

Limit: FCC:

Frequency range (MHz)	Fixed and base stations (±ppm)	Mobile stat	tions (±ppm)
Frequency range (IVIN2)	Fixed and base stations (appin)	Over 2 watts output power	2 watts or less output power
Below 25	100	100	200
25-50	20	20	50
72-76	5		50
150-174	5	5	50
216-220	1.0		1.0
220-222	0.1	1.5	1.5
421-512	2.5	5	5
806-809	1.0	1.5	1.5
809-824	1.5	2.5	2.5
851-854	1.0	1.5	1.5
854-869	1.5	2.5	2.5
896-901	0.1	1.5	1.5
902-928	2.5	2.5	2.5
902-928	2.5	2.5	2.5
929-930	1.5		
935-940	0.1	1.5	1.5
1427-1435	300	300	300
Above 2450			

14.1 EUT Operation

Operating Environment:

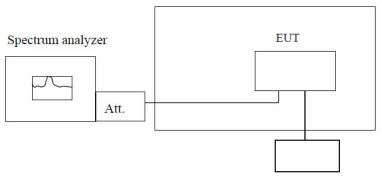
Temperature: 22.9 °C Humidity: 52.0 % RH

Atmospheric Pressure: 101.3kPa

14.2 Test Procedure

- 1. Set chamber temperature to 25 °C. Use a variable DC power source to power the EUT and set the voltage to rated voltage.
- 2. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.
- 3. Reduce the input voltage to specify extreme voltage variation (+/- 15%) and endpoint, record the maximum frequency change.

Temperature Chamber



Variable Power Supply

Note: Measurement setup for testing on Antenna connector

14.3 Test Result

Remark: All three channels of all modulations have been tested, but only the worst channel and the worst modulation show in this test item.

Test Frequency: 3652.5MHz QPSK 5MHz				
TemperaturePower SupplyFrequency ErrorFrequency Error(°C)(VDC)(Hz)(ppm)				
	105	104	0.0285	
25	120	107	0.0293	
	144	105	0.0287	

Test Frequency: 3655MHz QPSK 10MHz				
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)	
	105	107	0.0293	
25	120	106	0.0290	
	144	111	0.0304	

Test Frequency: 3657.5MHz QPSK 15MHz			
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)
	105	105	0.0287
25	120	110	0.0301
	144	108	0.0295

Test Frequency: 3660MHz QPSK 20MHz				
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)	
	105	106	0.0290	
25	120	116	0.0317	
	144	118	0.0322	

Test Frequency: 3652.5MHz QPSK 5MHz				
Temperature (°C)	Frequency Error (ppm)			
	105	110	0.0301	
25	120	100	0.0274	
	144	113	0.0309	

Test Frequency: 3655MHz QPSK 10MHz			
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)
	105	111	0.0304
25	120	112	0.0306
	144	114	0.0312

Test Frequency: 3657.5MHz QPSK 15MHz			
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)
	105	106	0.0290
25	120	115	0.0314
	144	103	0.0282

Test Frequency: 3660MHz QPSK 20MHz				
Temperature (°C)	Power Supply (VDC)	Frequency Error (Hz)	Frequency Error (ppm)	
	105	117	0.0320	
25	120	114	0.0311	
	144	107	0.0292	

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15 Photographs of Test Setup and EUT.

Note: Please refer to appendix: WTS17S1298632E_Photo.

===== End of Report =====